SHIGA7.040APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hayashi et al.

Appl. No. : 10/561,830

Filed : December 22, 2005

For : POSITIVE RESIST

COMPOSITION AND METHOD OF FORMING RESIST PATTERN

USING SAME

Examiner : Eoff, Anca

Group Art Unit : 1795

SUBMISSION WITH RCE

Mail Stop Amendment

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed **May 14, 2010**, please consider the following remarks:

The listing of claims begins on page 2 of this paper. No amendments have been made.

Remarks/Arguments begin on 4 of this paper.